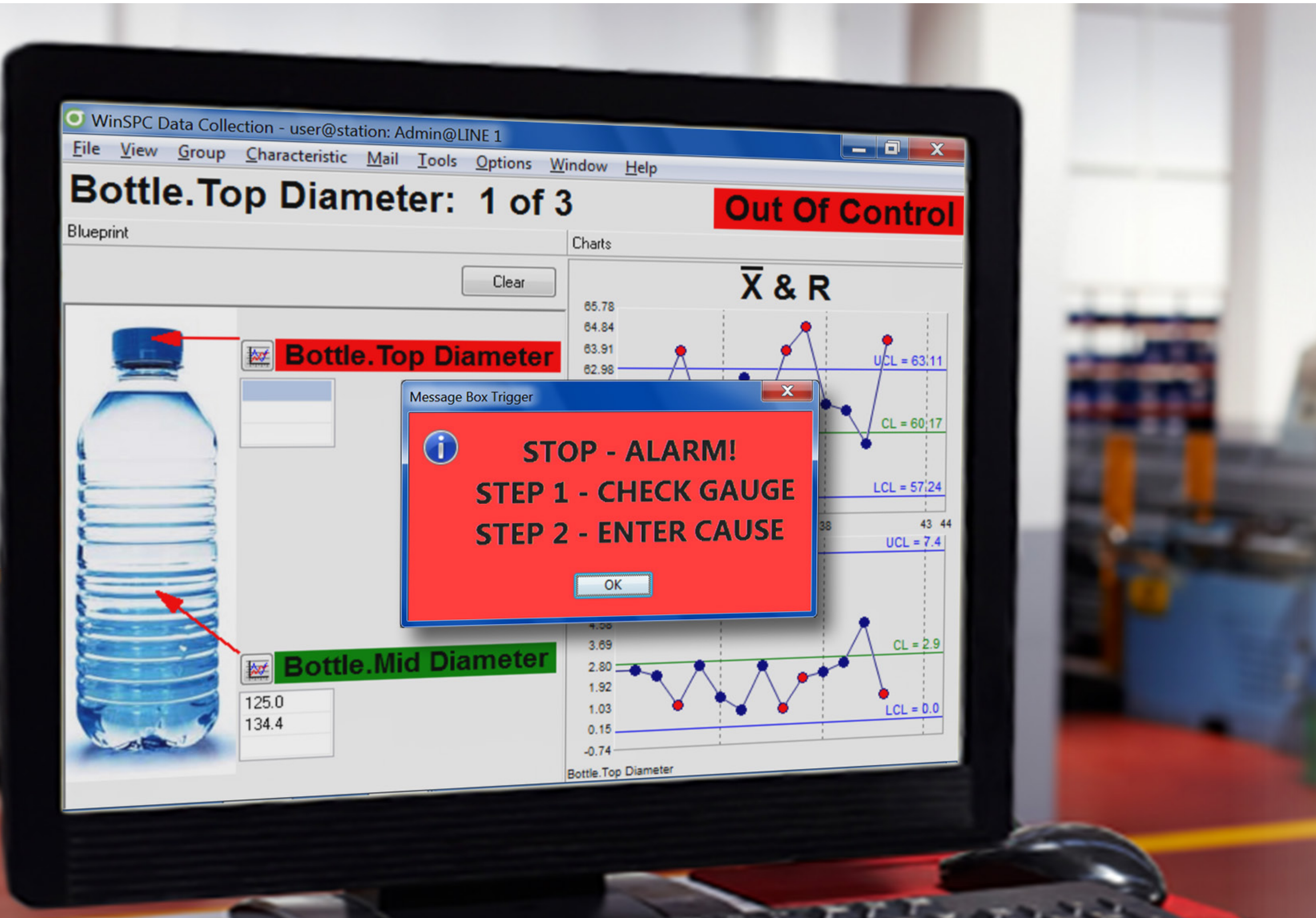


WHY DO SPC?

*SPC helps companies make the **HIGHEST QUALITY PRODUCT** at the **LOWEST POSSIBLE COST**.*



SPC allows you to monitor the performance of a process and, using statistics, helps you **IDENTIFY TRENDS** and **VARIATION** in the process to **PREVENT** the process from going out of control.

BENEFITS OF AUTOMATED SPC

Statistical Process Control

- MONITOR PROCESSES IN REAL-TIME
- IMPROVE QUALITY
- REDUCE PROCESS VARIATION, SCRAP, & REWORK
- ELIMINATE PAPERWORK
- COMPLY WITH CUSTOMER & REGULATORY REQUIREMENTS

VARIATION

SPC control charts help identify Assignable Cause variation and prevent non-conformances.

**RANDOM
VARIATION**

**ASSIGNABLE
CAUSE VARIATION**



ALL PROCESSES HAVE VARIATION

2 Variation Types

RANDOM VARIATION is normal and ok

ASSIGNABLE CAUSE VARIATION means a process is **OUT OF CONTROL**

KEY TERMS

MEAN | average of readings

SIGMA | spread of readings (process distribution)

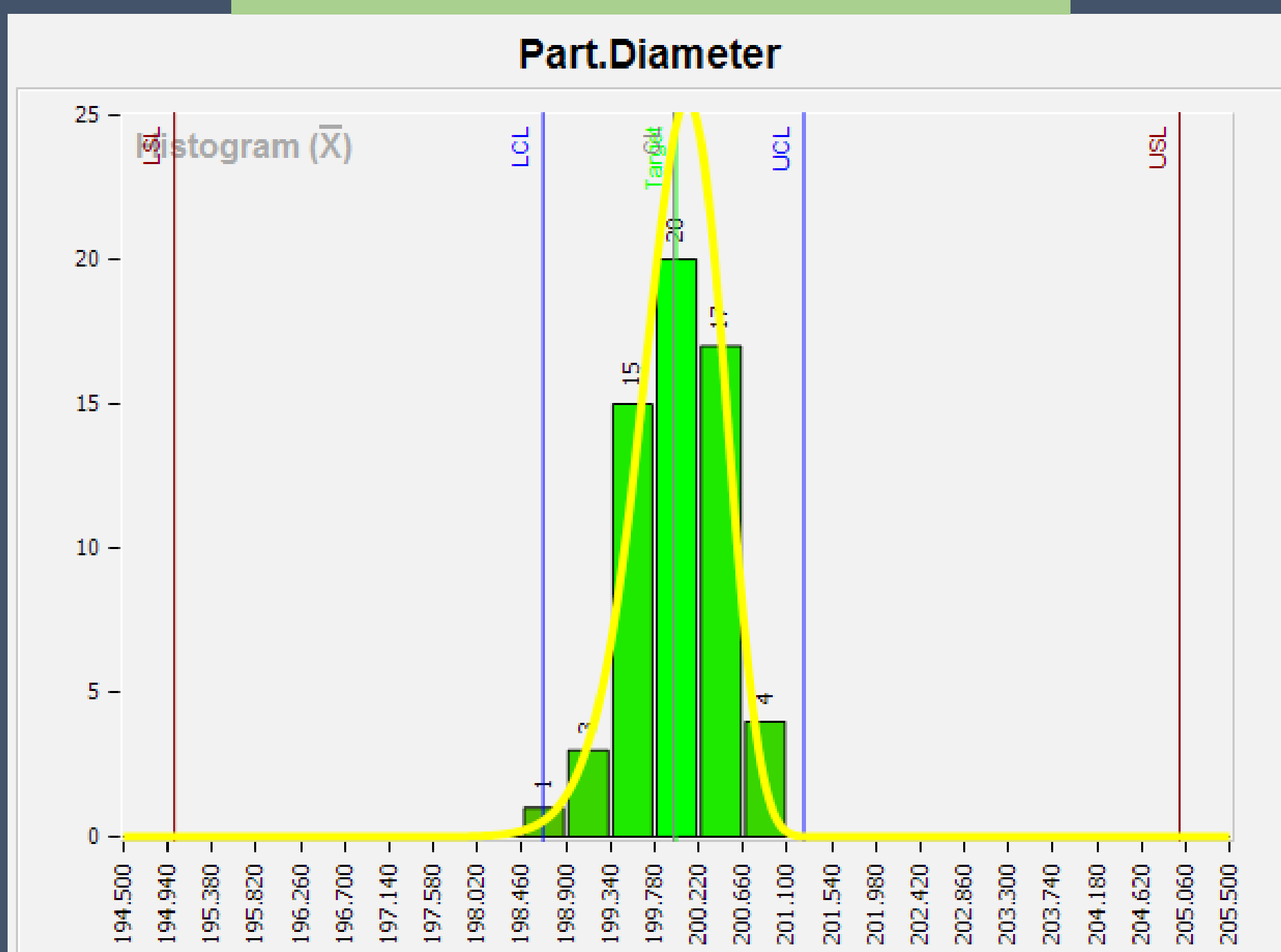
STANDARD DEVIATION | measure of the difference from a target value

SUBGROUP SIZE | number of readings used to plot an average

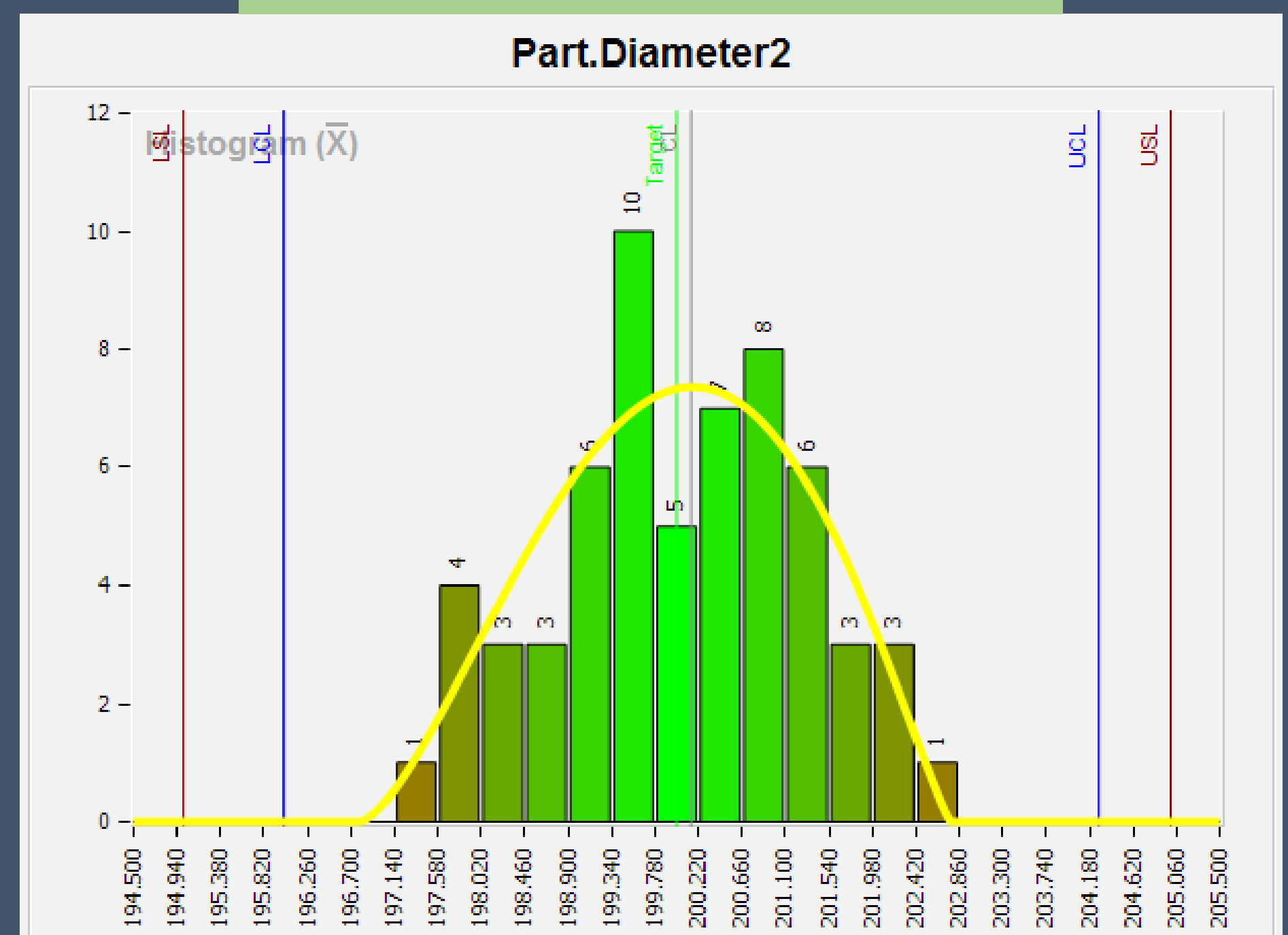
PROCESS CAPABILITY

A method of analyzing a process to see how capable the process is of meeting the desired specification limits.

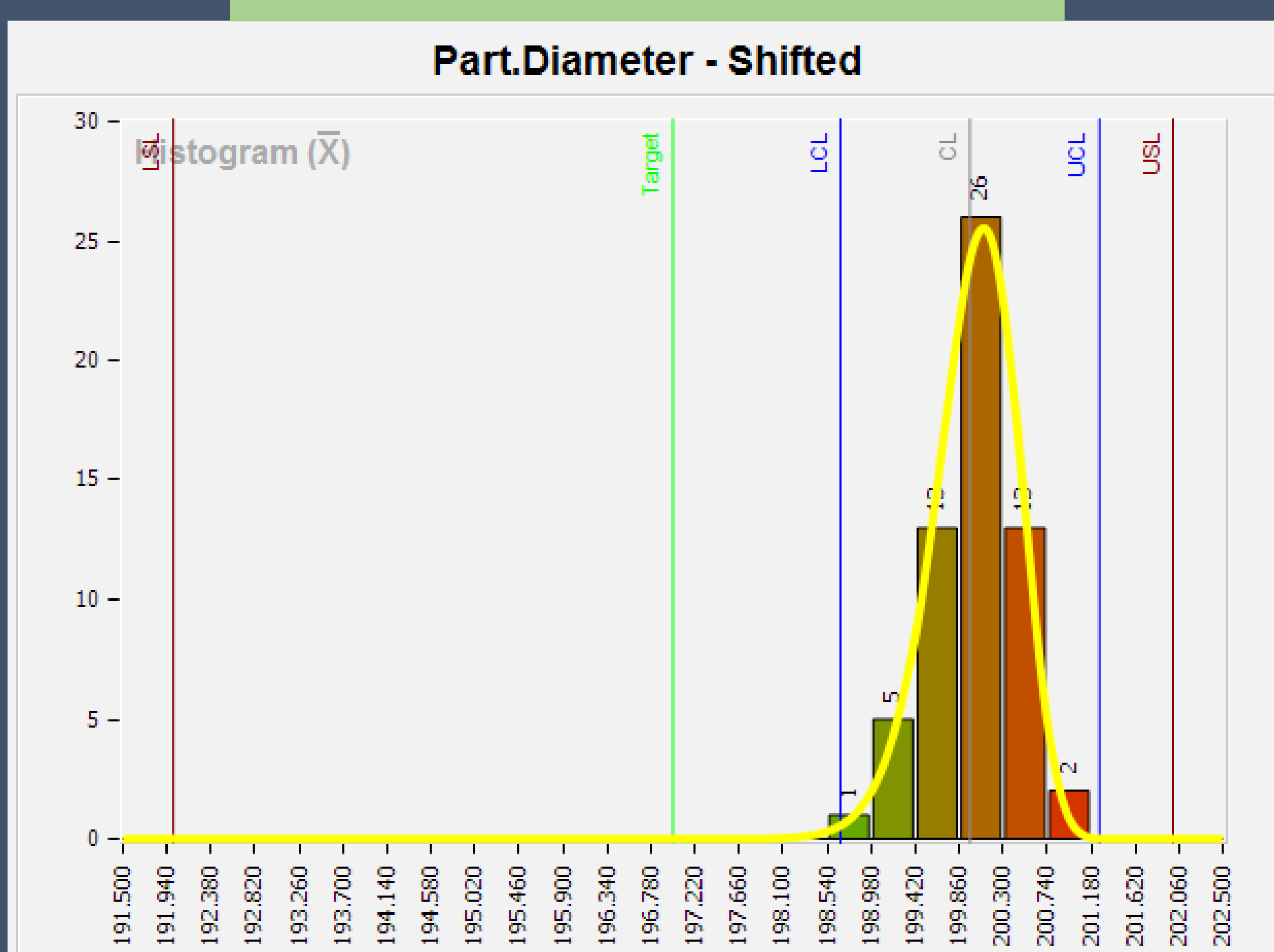
High Cpk | High Cp
Cpk = 1.68 | Cp = 1.68



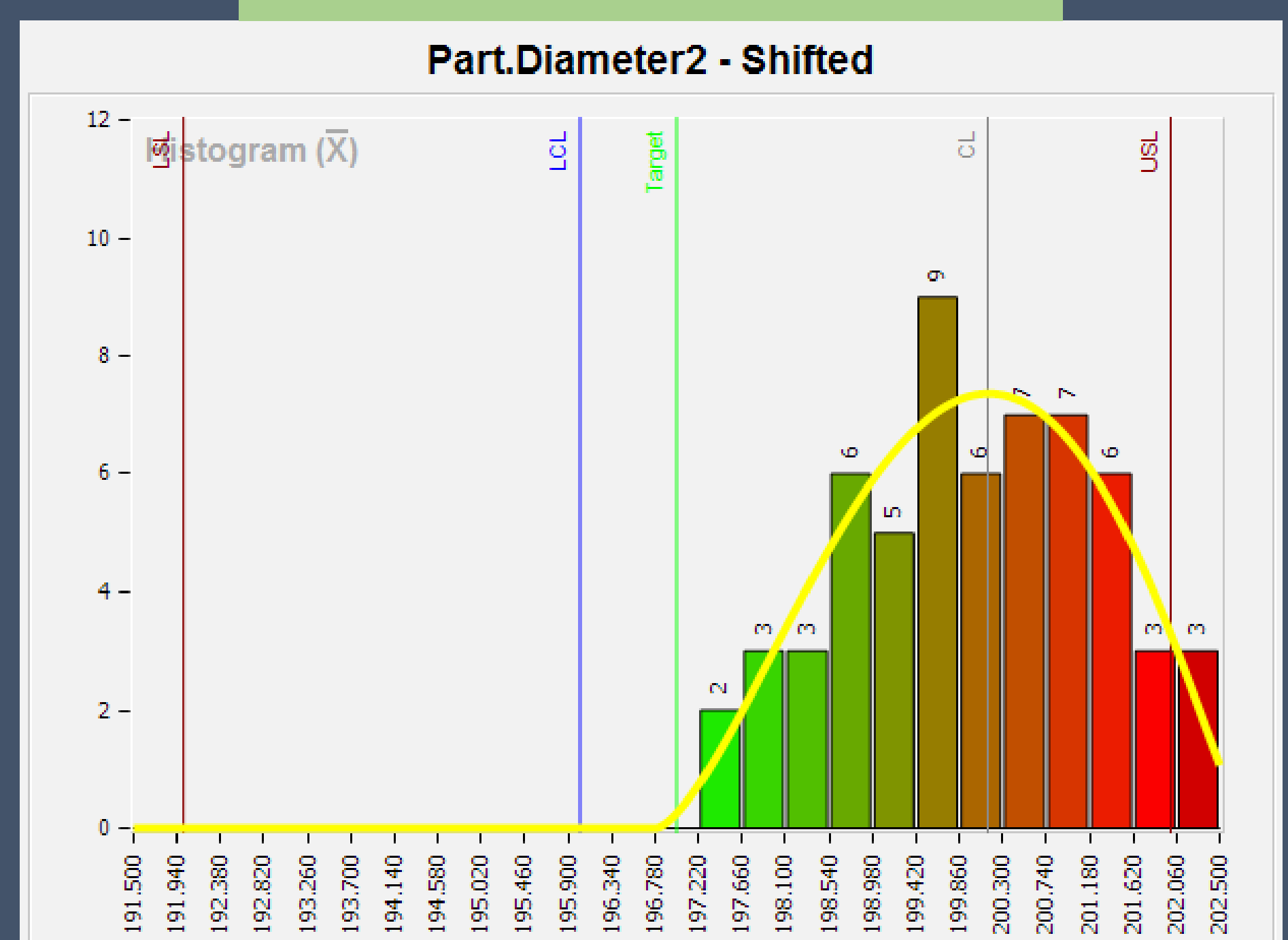
Low Cpk | Low Cp
Cpk = .53 | Cp = .53



Low Cpk | High Cp
Cpk = .67 | Cp = 1.68



Low Cpk | Low Cp
Cpk = .21 | Cp = .53



KEY TERMS

HISTOGRAM | Tally of measurements that shows the distribution of the data

CP | Measure of how narrow or wide is the distribution of data (spread) (Target Cp > 1.3)

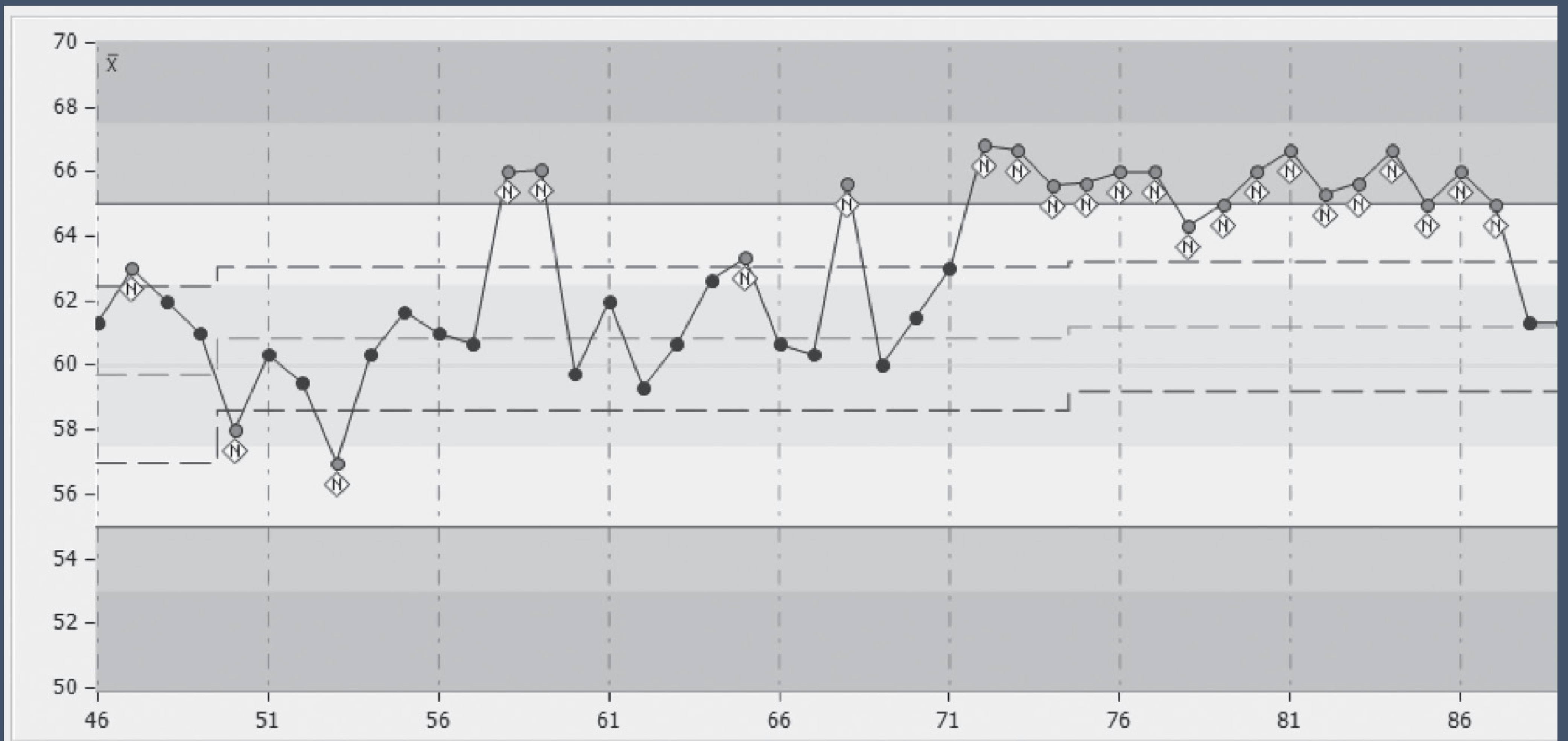
CPK | Measure of the data spread and how well centered the data is within the specification limits (spread and centering) (Target Cpk > 1.3)

LIMITS

-- SPECIFICATION LIMITS --

The voice of the **CUSTOMER**:
TOLERANCE DICTATED by customer

NOTE: A point outside specification limits indicates that the part is out of tolerance (defective).



-- CONTROL LIMITS --

The voice of the **PROCESS**:
Calculated limits **BASED ON PROCESS DATA**

NOTE: A point outside the control limits indicates that the process is out of control.

CONTROL CHART

A chart to visualize how a process is performing against calculated control limits and to reveal variation among measurements.

A PLOT OF DATA AGAINST CONTROL LIMITS



KEY TERMS

XBAR | **AVERAGE** of multiple measurements (*Subgroup Size>1*)

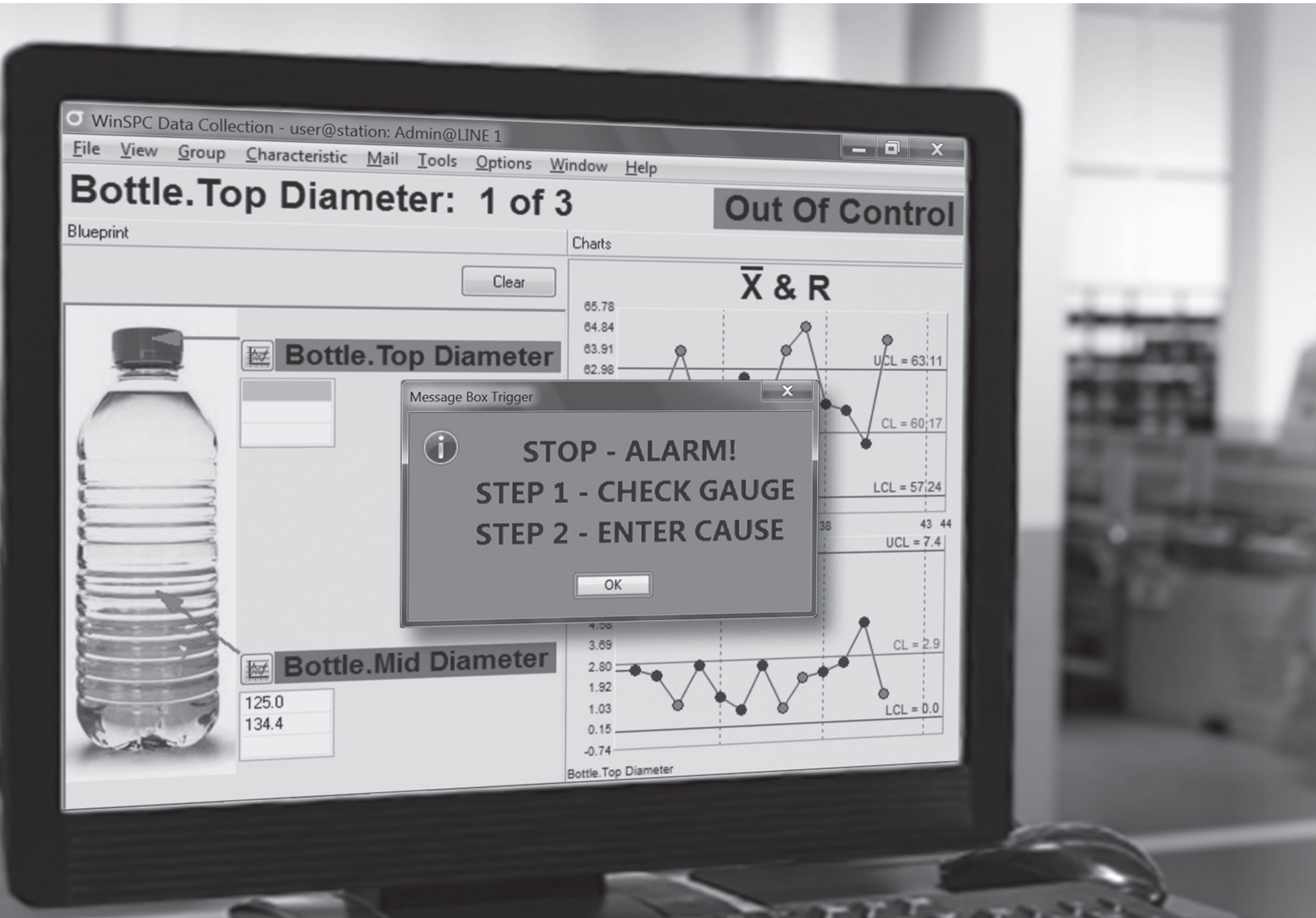
R | **RANGE** is the difference between the lowest and highest values in a set of measurements

X | Plot of **INDIVIDUAL MEASUREMENTS** (*Subgroup Size=1*)

MR | **DIFFERENCE BETWEEN** multiple measurements

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Statistical Process Control

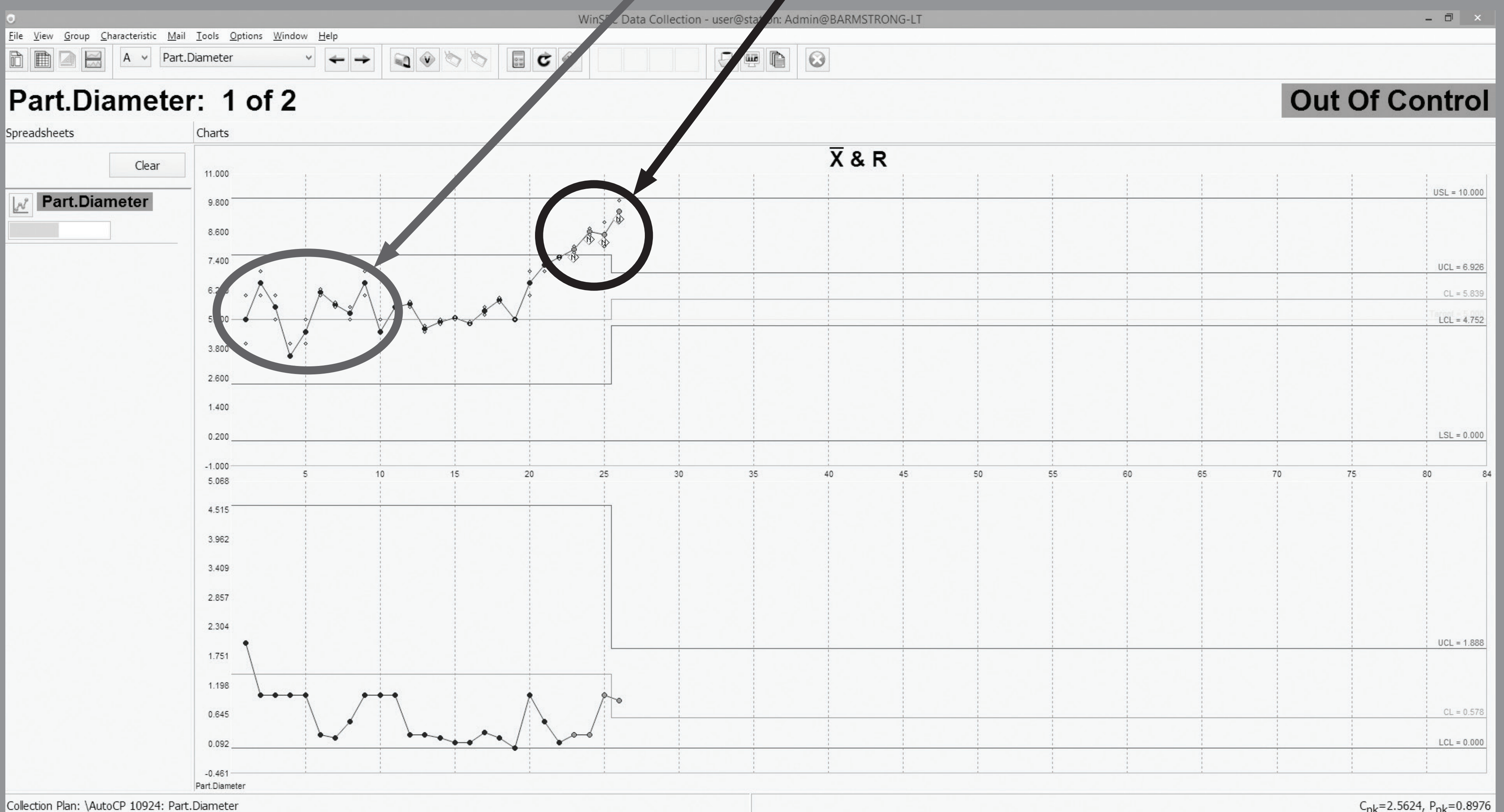
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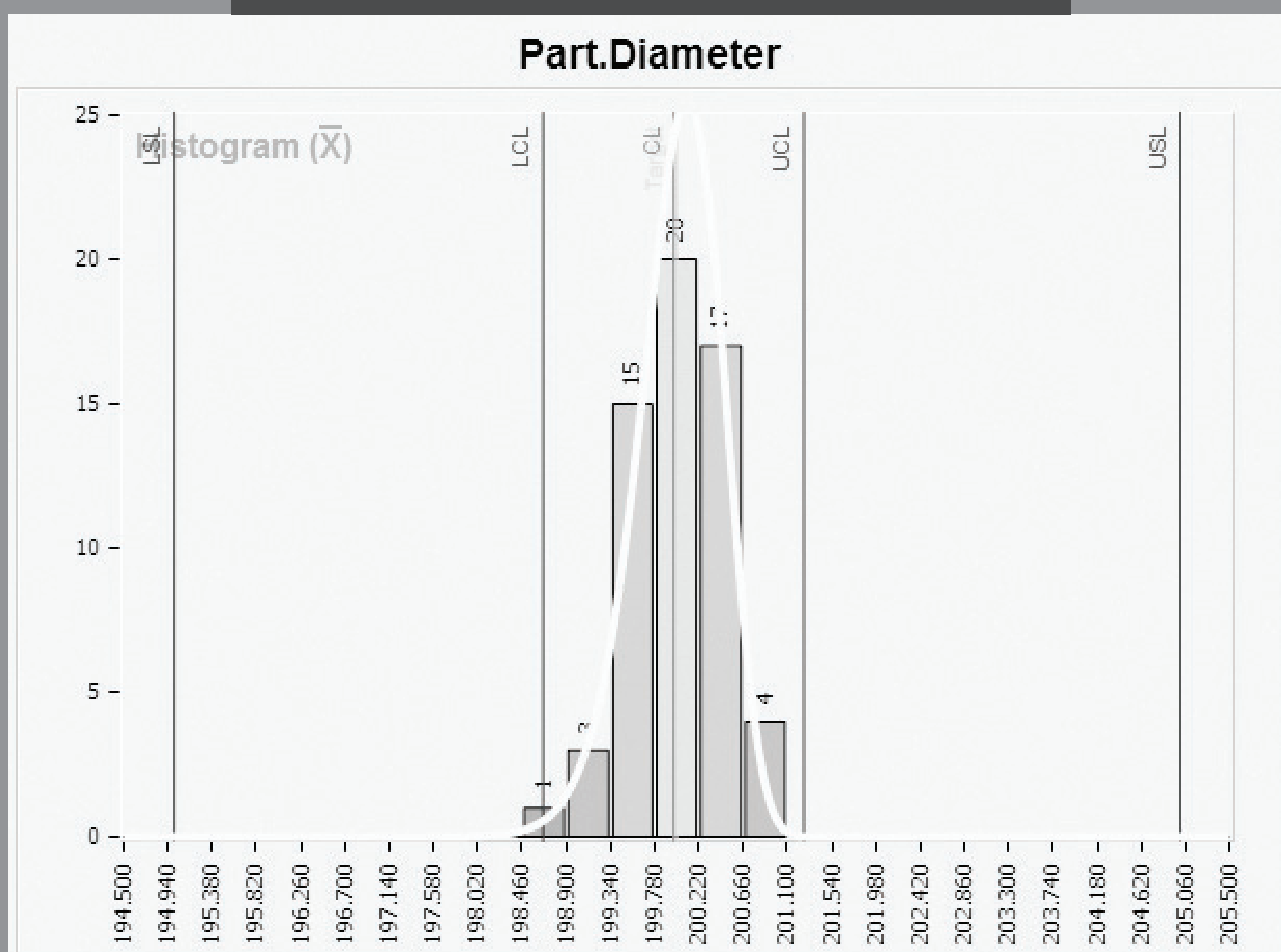
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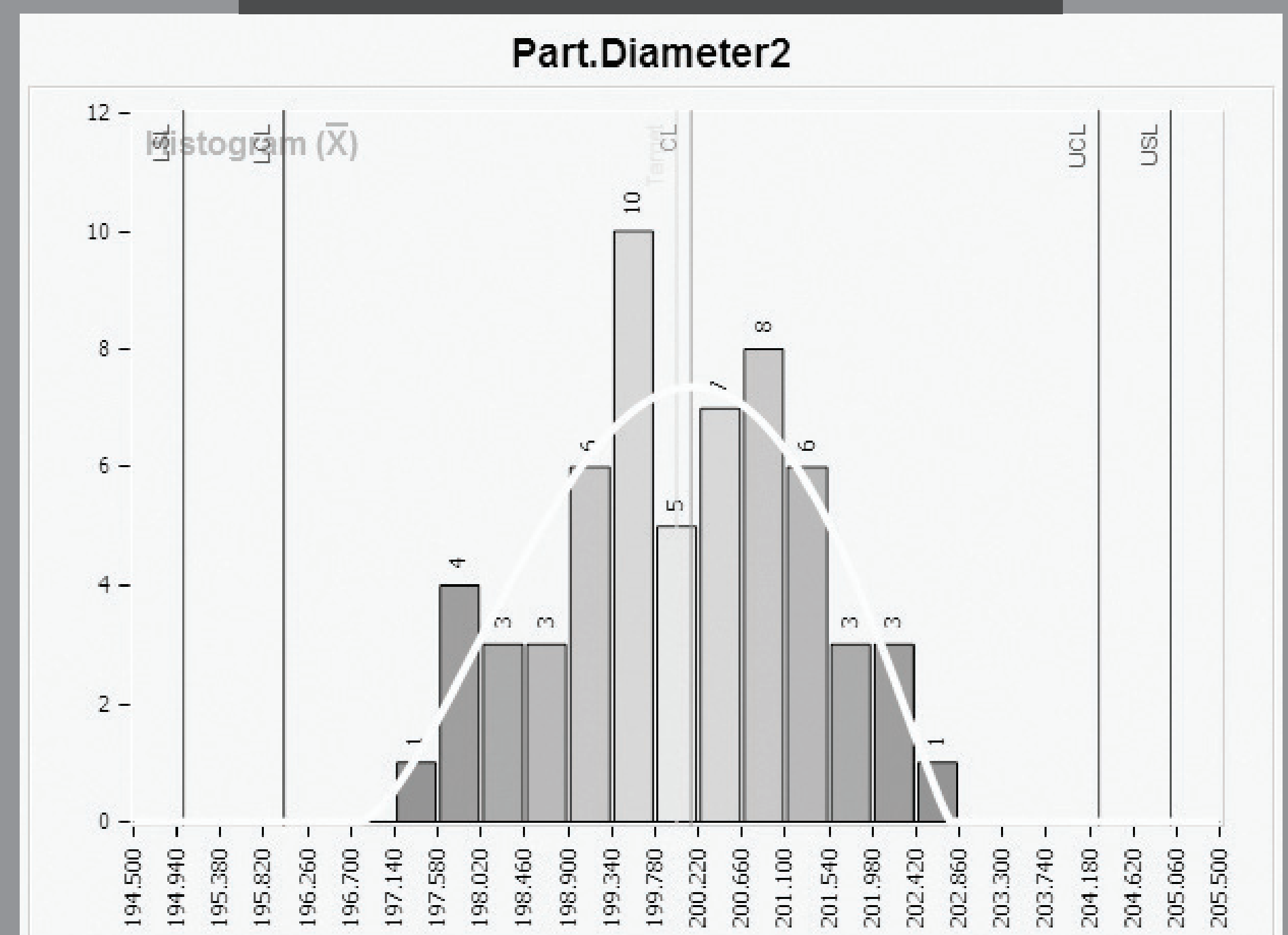
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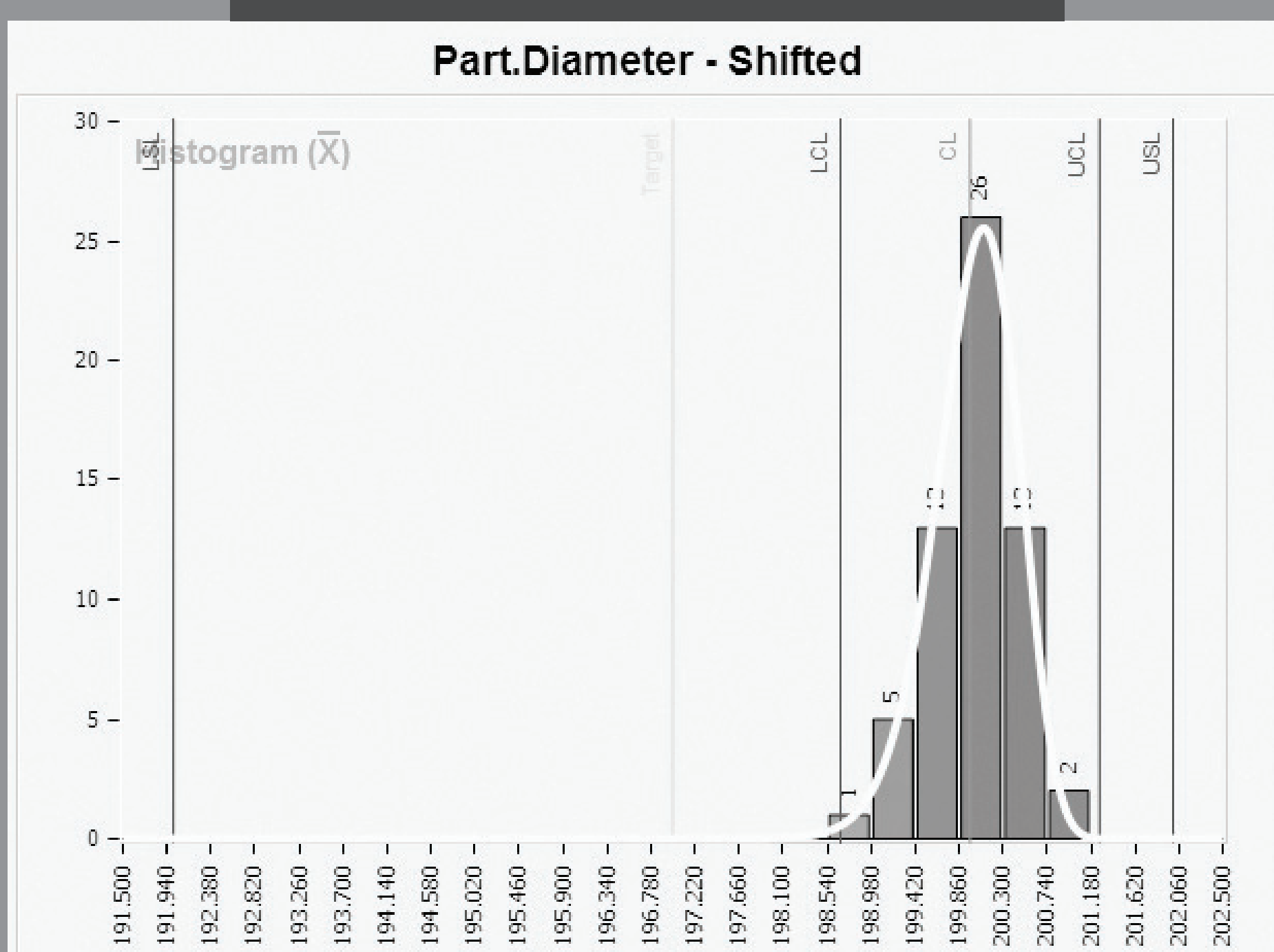
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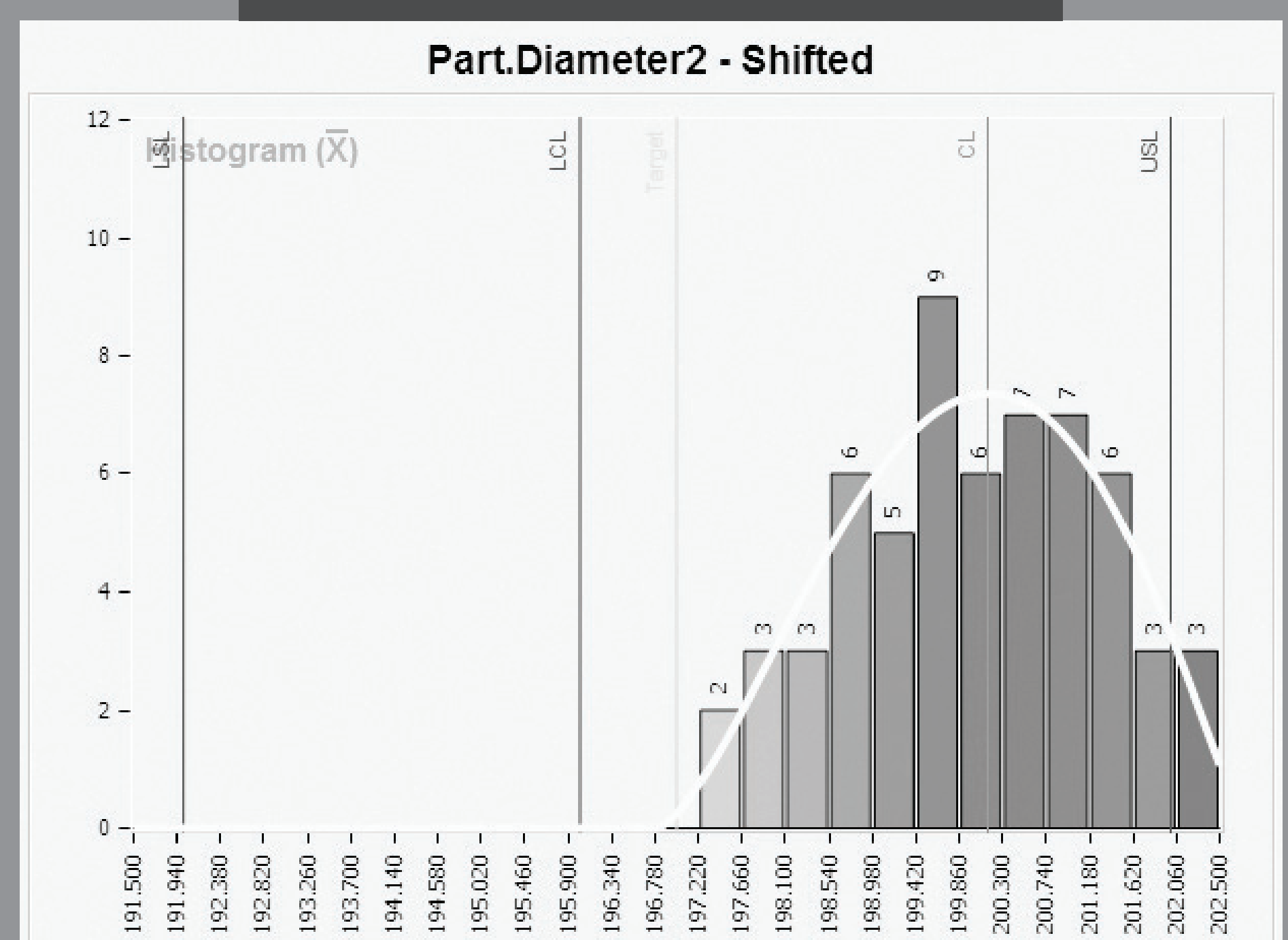
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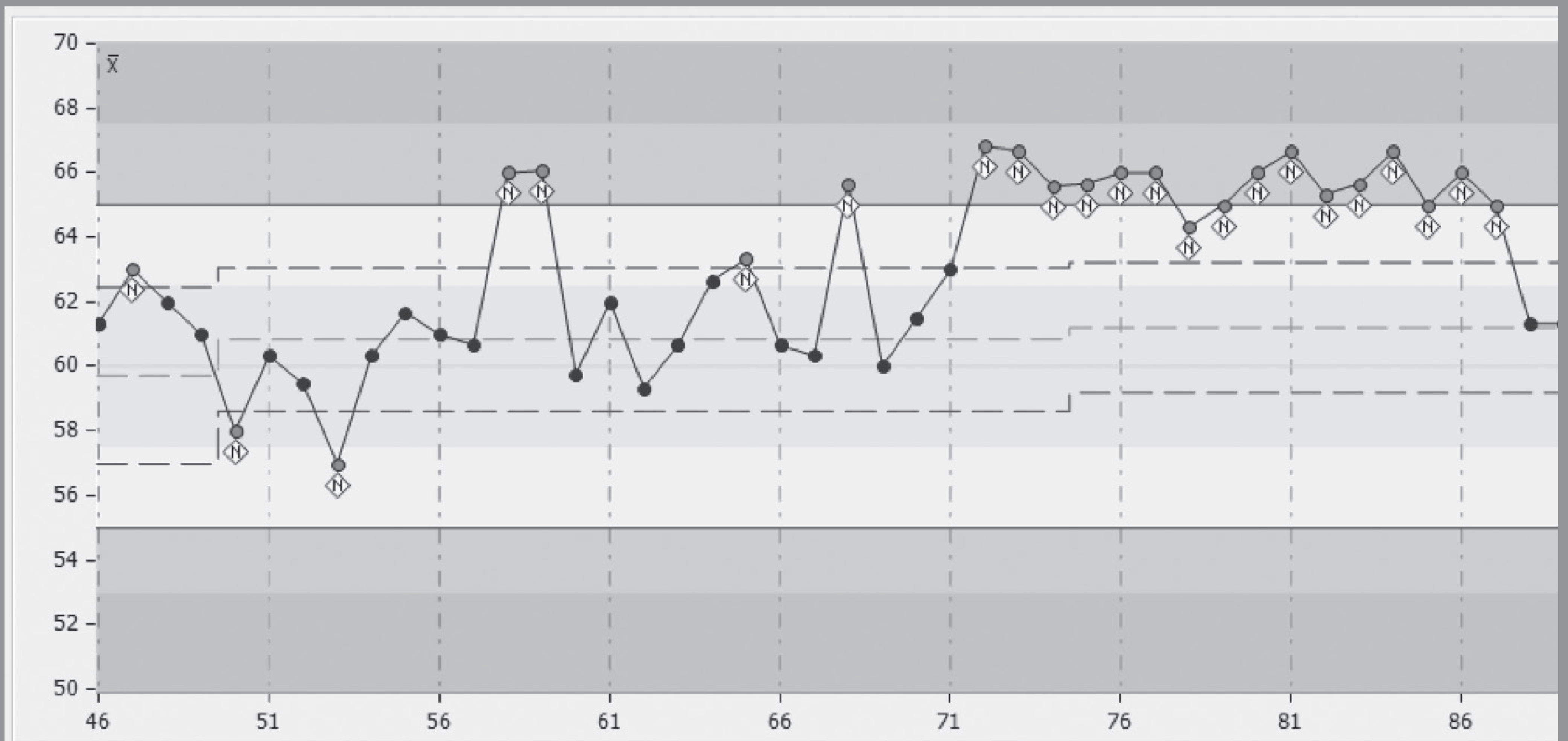
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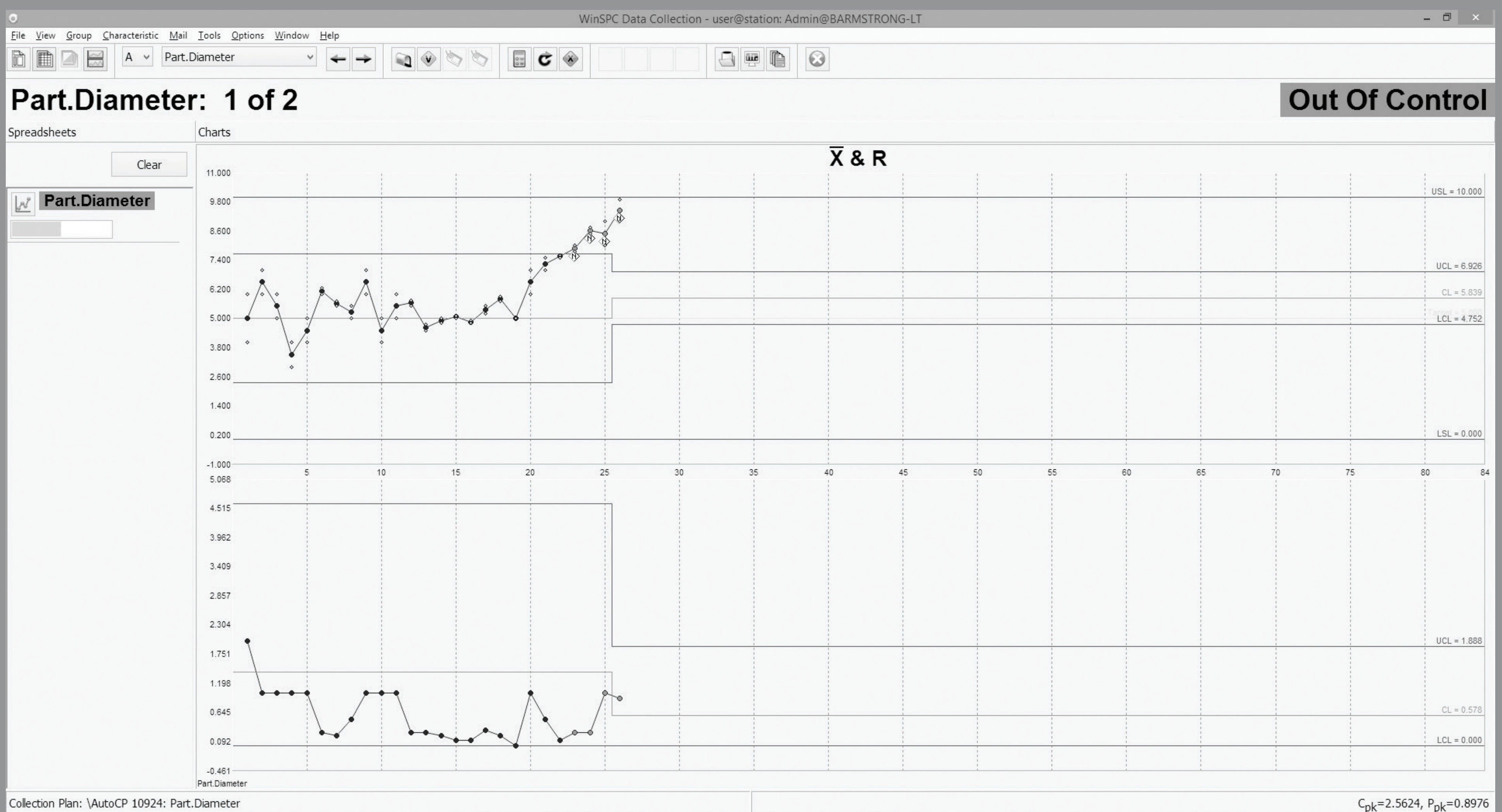
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